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INFORMATION DISCLOSURE STATEMENT BY APPLICANT (use as many sheets as necessary)		Application Number	09/748,166
		Filing Date	December 27, 2000
		First Named Inventor	Shunpei YAMAZAKI
		Group Art Unit	2871
		Examiner Name	D. Nguyen
Sheet 1 of 1	Attorney Docket Number	0756-2235	

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Examiner Signature	D. NGUYEN					Date Considered	11/27/04	

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